

NUS3116MT

Main Switch Power MOSFET and Dual Charging BJT

-12 V, -6.2 A, μ COOL™ Single P-Channel with Dual PNP low $V_{ce(sat)}$ Transistors, 3x3 mm WDFN Package

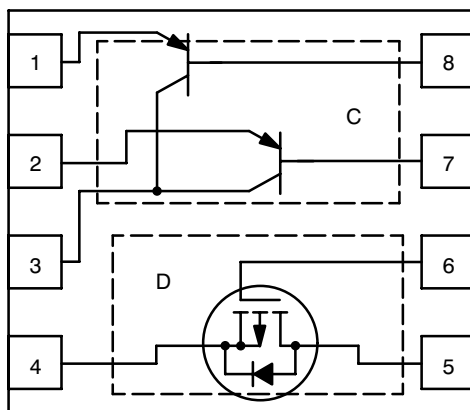
This device integrates one high performance power MOSFET and two low $V_{ce(sat)}$ transistors, greatly reducing the layout space and optimizing charging performance in the battery-powered portable electronics.

Features

- High Performance Power MOSFET
- Dual-Low $V_{ce(sat)}$ Transistors as Charging Power Mux
- 3.0x3.0x0.8 mm WDFN Package
- Independent Pin-out Provides Circuit Flexibility
- Low Profile (<0.8 mm) for Easy Fit in Thin Environments
- This is a Pb-Free Device

Applications

- Main Switch and Battery Charging Mux for Portable Electronics
- Optimized for Commercial PMUs from Top Suppliers (See Figure 2)



μ COOL™ 3x3 Pin Connections (Top View)

Figure 1. Simple Schematic



ON Semiconductor®

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MOSFET

$V_{(BR)DSS}$	$R_{DS(on)}$ TYP	I_D MAX
-12 V	32 m Ω @ -4.5 V	-6.2 A
	44 m Ω @ -2.5 V	

Low $V_{ce(sat)}$ PNP (Wall)

V_{CE0} MAX	V_{EBO} MAX	I_C MAX
-30 V	-8.0 V	-2.0 A

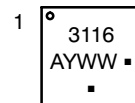
Low $V_{ce(sat)}$ PNP (USB)

V_{CE0} MAX	V_{EBO} MAX	I_C MAX
-30 V	-8.0 V	-2.0 A



DFN8
CASE 506BC

MARKING DIAGRAM



3116 = Device Code
 A = Assembly Location
 Y = Year
 WW = Work Week
 ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping†
NUS3116MTR2G	WDFN8 (Pb-Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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P-Channel Power MOSFET Maximum Ratings ($T_J = 25^\circ\text{C}$ unless otherwise stated)

Parameter		Symbol	Value	Units	
Drain-to-Source Voltage		V_{DS}	-12	V	
Gate-to-Source Voltage		V_{GS}	± 8.0	V	
Continuous Drain Current (Note 1)	Steady State	$T_A = 25^\circ\text{C}$	-5.47	A	
		$T_A = 85^\circ\text{C}$	-4.0		
	$t \leq 5 \text{ s}$	$T_A = 25^\circ\text{C}$	-6.2		
Power Dissipation (Note 1)	Steady State	$T_A = 25^\circ\text{C}$	1.7	W	
	$t \leq 5 \text{ s}$		2.2		
Continuous Drain Current (Note 2, Minimum Pad)	Steady State	$T_A = 25^\circ\text{C}$	-4.4	A	
		$T_A = 85^\circ\text{C}$	-3.2		
	Power Dissipation (Note 2)	$T_A = 25^\circ\text{C}$	P_D	1.14	W
Pulsed Drain Current	$t_p = 10 \mu\text{s}$		I_{DM}	-25	A
Operating Junction and Storage Temperature		T_J, T_{STG}	-55 to 150	$^\circ\text{C}$	
Source Current (Body Diode) ²		I_S	-2.8	A	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T_L	260	$^\circ\text{C}$	

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient – Steady State (Note 2)	$R_{\theta JA}$	110	$^\circ\text{C/W}$
Junction-to-Ambient – $t < 10 \text{ s}$ (Note 2)	$R_{\theta JA}$	56	$^\circ\text{C/W}$
Junction-to-Ambient – Steady State (Note 1)	$R_{\theta JA}$	72	$^\circ\text{C/W}$
Junction-to-Ambient – $t < 10 \text{ s}$ (Note 1)	$R_{\theta JA}$	40	$^\circ\text{C/W}$

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- Surface-mounted on FR4 board using the minimum recommended pad size of 0.5 in sq, 1 oz. Cu.

P-Channel MOSFET Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-12.0			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$	$I_D = -250 \mu\text{A}, \text{ref to } 25^\circ\text{C}$		-10.1		$\text{mV}/^\circ\text{C}$
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS} = 0 \text{ V}, V_{DS} = -12 \text{ V}$	$T_J = 25^\circ\text{C}$		-1.0	μA
			$T_J = 125^\circ\text{C}$		-10	
Gate-to-Source Leakage Current	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 200	nA

ON CHARACTERISTICS (Note 3)

Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = -250 \mu\text{A}$	-0.45	-0.67	-1.1	V
Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$			2.68		$\text{mV}/^\circ\text{C}$
Drain-to-Source On Resistance	$R_{DS(on)}$	$V_{GS} = -4.5 \text{ V}, I_D = -3.0 \text{ A}$		32	40	$\text{m}\Omega$
		$V_{GS} = -2.5 \text{ V}, I_D = -3.0 \text{ A}$		44	50	
Forward Transconductance	g_{FS}	$V_{DS} = -16 \text{ V}, I_D = -3.0 \text{ A}$		5.9		S

- Pulsed Condition: Pulse Width = 300 μsec , Duty Cycle $\leq 2\%$

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P-Channel MOSFET Electrical Characteristics (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
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CHARGES, CAPACITANCES AND GATE RESISTANCE

Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = -12 V		1329		pF
Output Capacitance	C _{OSS}			200		
Reverse Transfer Capacitance	C _{RSS}			116		
Total Gate Charge	Q _{G(tot)}	V _{GS} = -4.5 V, V _{DS} = -12 V, I _D = -3.0 A		13		nC
Threshold Gate Charge	Q _{G(th)}			1.5		
Gate-to-Source Charge	Q _{GS}			2.2		
Gate-to-Drain Charge	Q _{GD}			2.9		

SWITCHING CHARACTERISTICS

Turn-On Delay Time	t _{d(on)}	V _{GS} = -4.5 V, V _{DD} = -12 V, I _D = -3.0 A, R _G = 3.0		8		ns
Rise Time	t _r			17.5		
Turn-Off Delay Time	t _{d(off)}			80		
Fall Time	t _f			56.5		

DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Recovery Voltage	V _{SD}	V _{GS} = 0 V, I _S = -1.0 A	T _J = 25°C		-0.66	-1.2	V
			T _J = 125°C		-0.54		
Reverse Recovery Time	t _{rr}	V _{GS} = 0 V, dI _{SD} /dt = 100 A/μs, I _S = -1.0 A		70.8		ns	
Charge Time	t _a			14.3			
Discharge Time	t _b			56.4			
Reverse Recovery Charge	Q _{RR}			44		nC	

3. Pulsed Condition: Pulse Width = 300 μsec, Duty Cycle ≤ 2%

Dual-PNP Transistors Maximum Ratings (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Units
Collector-Emitter Voltage	V _{CEO}	-30	V
Collector-Base Voltage	V _{CBO}	-30	V
Emitter-Base Voltage	V _{EBO}	-8.0	V
Collector Current, Continuous	I _C	-2.0	A
Collector Current, Pulsed (Note 4)	I _C	-6.0	A
Operating Junction and Storage Temperature	T _J , T _{STG}	-55 to 150	°C
Thermal Resistance Dissipation	P _D	1.5	W
Thermal Resistance (Note 5)	R _{θJA}	83	°C/W
Thermal Resistance Dissipation	P _D	810	mW
Thermal Resistance (Note 6)	R _{θJA}	155	°C/W

4. Single Pulse: Pulse Width = 1 ms

5. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)

6. Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm², 1 oz. Cu.

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Dual-PNP Transistors Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
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OFF CHARACTERISTICS

Collector-Emitter Voltage	V_{CE0}	$I_C = -10\text{ mA}, I_B = 0$	-30			V
Collector-Base Voltage	V_{CBO}	$I_C = -0.1\text{ mA}, I_E = 0$	-30			V
Emitter-Base Voltage	V_{EBO}	$I_E = -0.1\text{ mA}, I_C = 0$	-8.0			V
Collector-Emitter Cutoff Current	I_{CES}	$V_{CES} = -30\text{ V}$			-0.1	μA

ON CHARACTERISTICS

DC Current Gain (Note 7)	h_{FE}	$I_C = -1.0\text{ A}, V_{CE} = -2.0\text{ V}$	100	200		-
DC Current Gain (Note 7)	h_{FE}	$I_C = -2.0\text{ A}, V_{CE} = -2.0\text{ V}$	100	200		-
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -1.0\text{ A}, I_B = -0.01\text{ A}$			0.22	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -1.0\text{ A}, I_B = -0.1\text{ A}$			0.12	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -2.0\text{ A}, I_B = -0.2\text{ A}$			0.24	V
Input Capacitance	C_{ibo}	$V_{EB} = -0.5\text{ V}, f = 1.0\text{ MHz}$		240	400	pF
Output Capacitance	C_{obo}	$V_{CB} = -3.0\text{ V}, f = 1.0\text{ MHz}$		50	100	pF

7. Pulsed Condition: Pulse Width = 300 μsec , Duty Cycle $\leq 2\%$

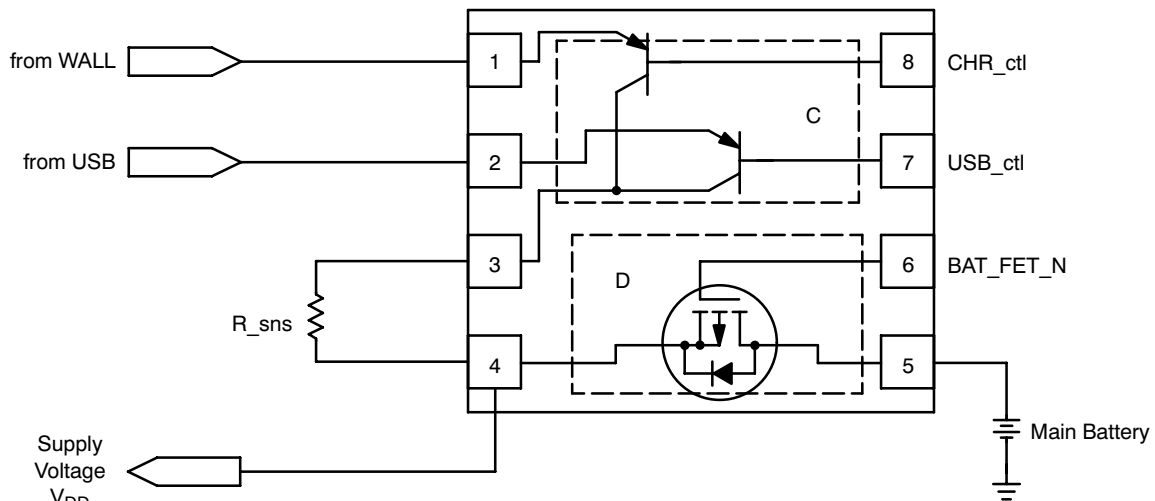


Figure 2. Typical Application Circuit

TYPICAL CHARACTERISTICS - MOSFET

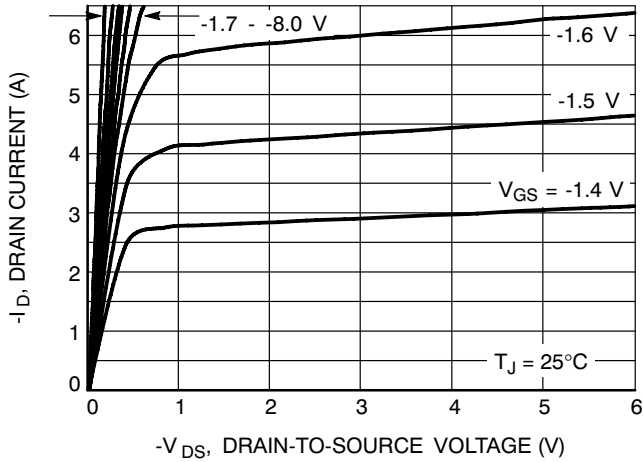


Figure 3. On-Region Characteristics

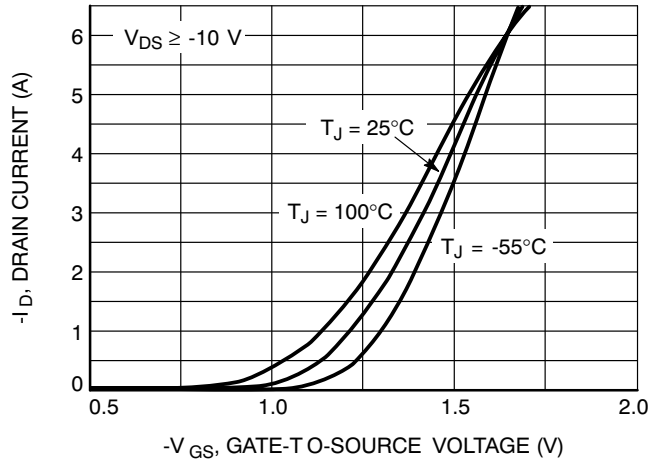


Figure 4. Transfer Characteristics

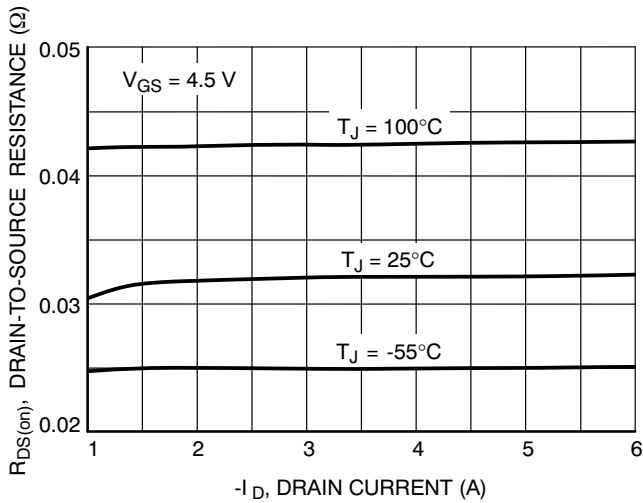


Figure 5. On-Resistance vs. Drain Current

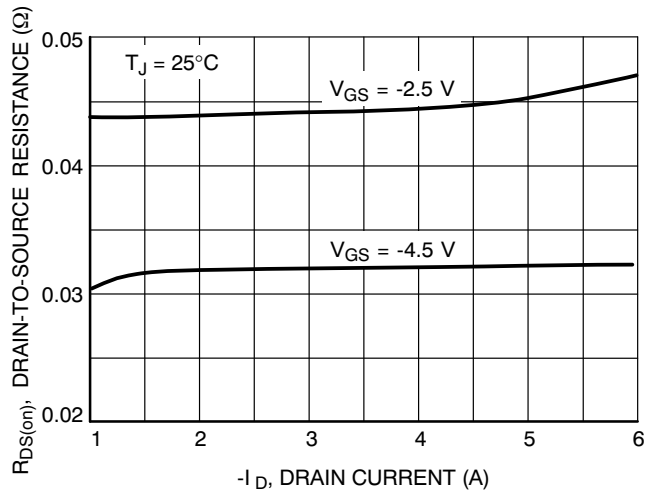


Figure 6. On-Resistance vs. Drain Current and Gate Voltage

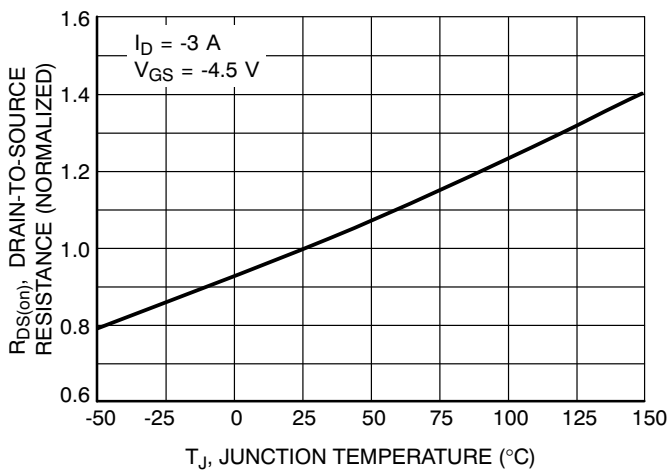


Figure 7. On-Resistance Variation with Temperature

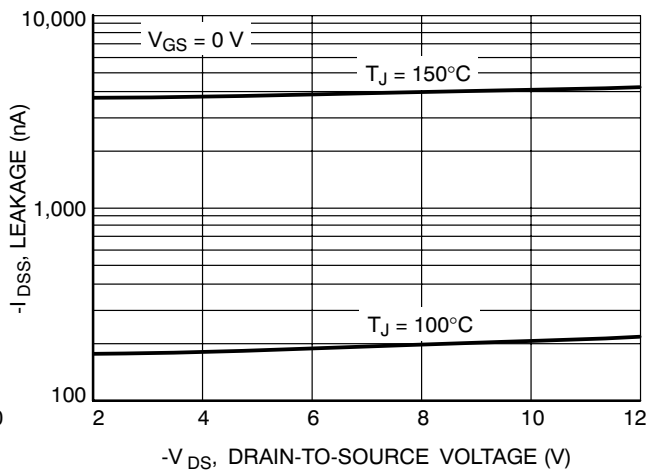


Figure 8. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS - MOSFET

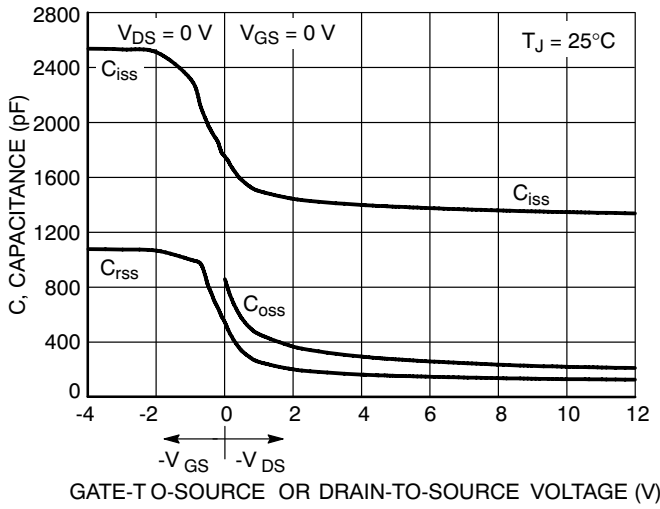


Figure 9. Capacitance Variation

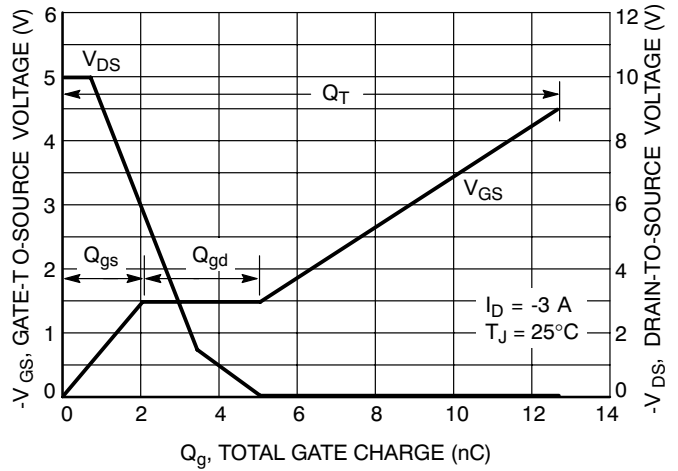


Figure 10. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

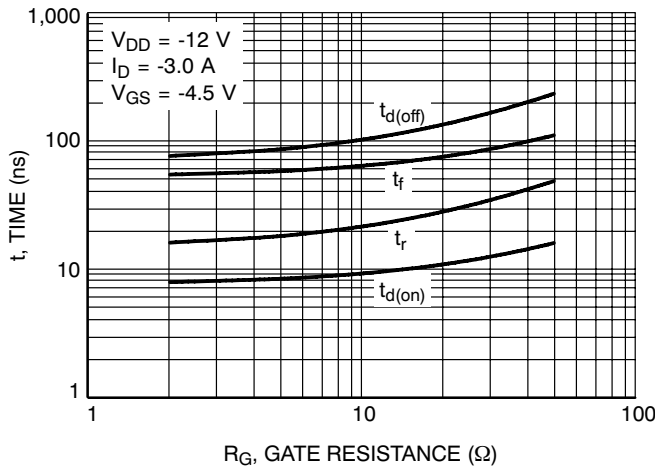


Figure 11. Resistive Switching Time Variation vs. Gate Resistance

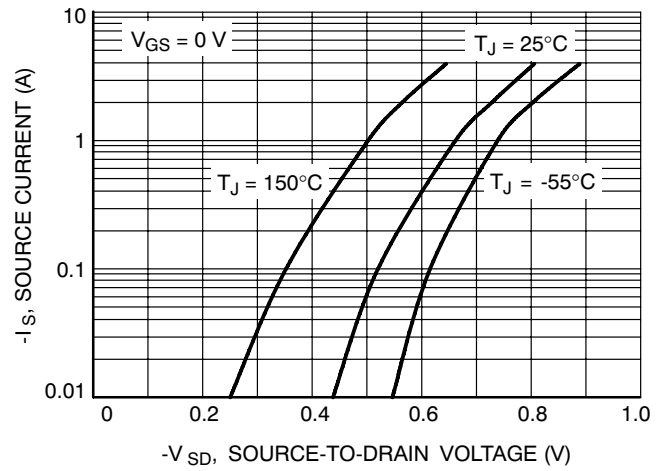
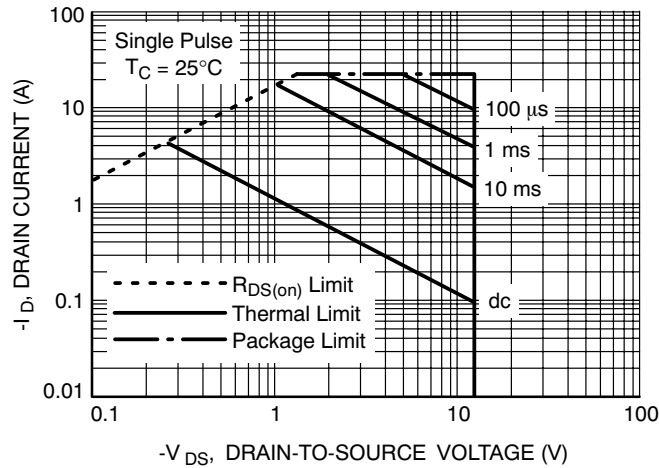


Figure 12. Diode Forward Voltage vs. Current



Mounted on 2" sq. FR4 board (0.5" sq. 2 oz. Cu single sided) with MOSFET die operating.

Figure 13. Maximum Rated Forward Biased Safe Operating Area

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TYPICAL CHARACTERISTICS - MOSFET

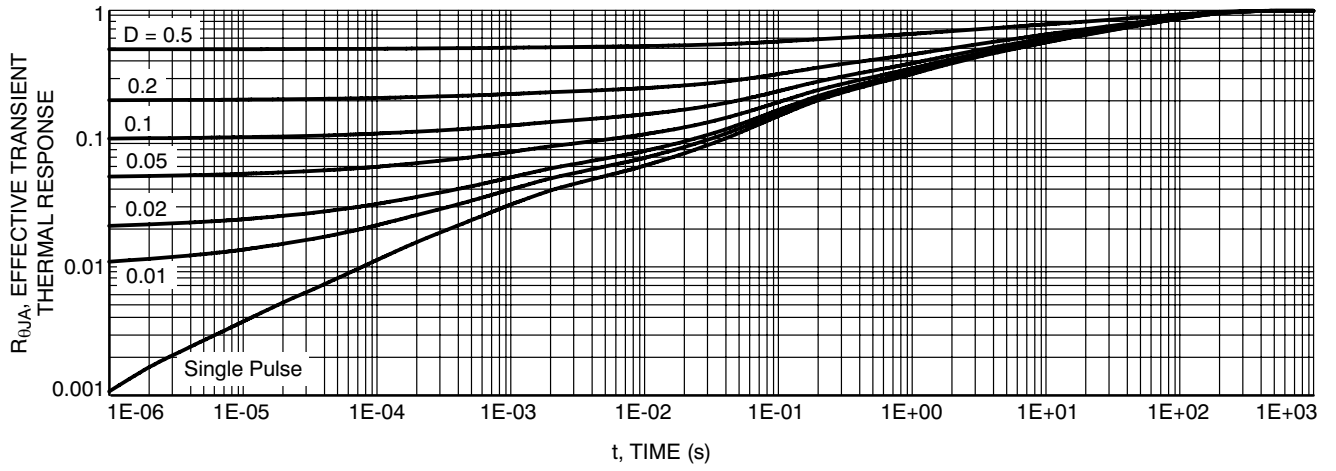


Figure 14. FET Thermal Response

TYPICAL CHARACTERISTICS - BJT

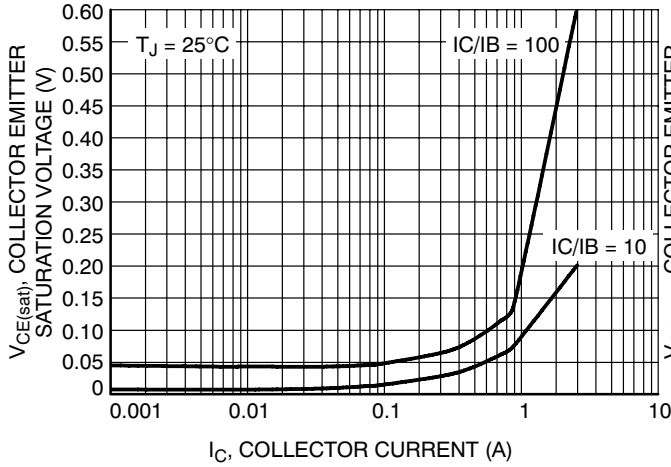


Figure 15. Collector Emitter Saturation Voltage vs. Collector Current

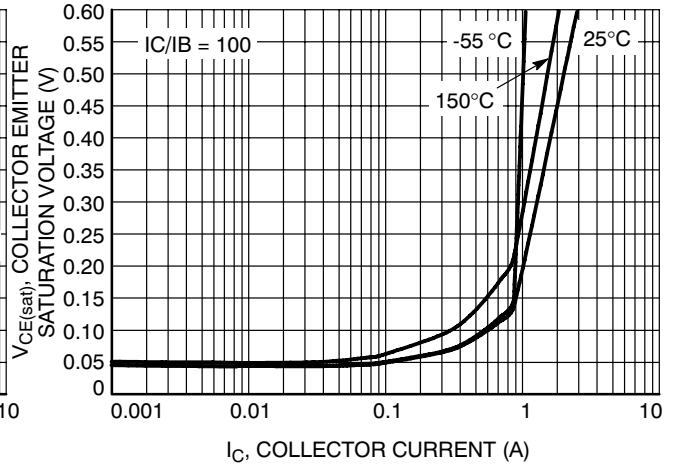


Figure 16. Collector Emitter Saturation Voltage vs. Collector Current

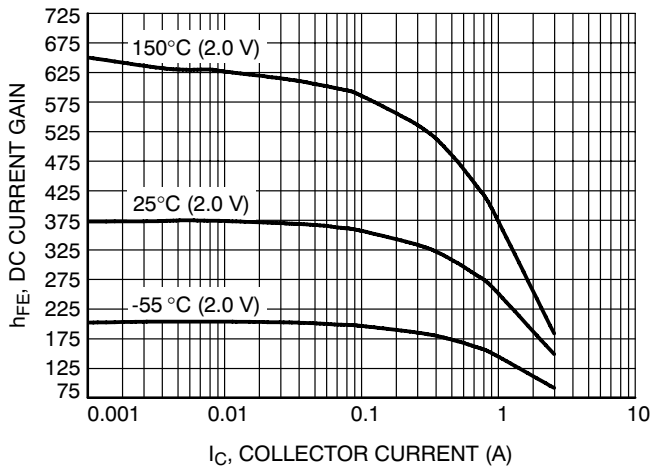


Figure 17. DC Current Gain vs. Collector Current

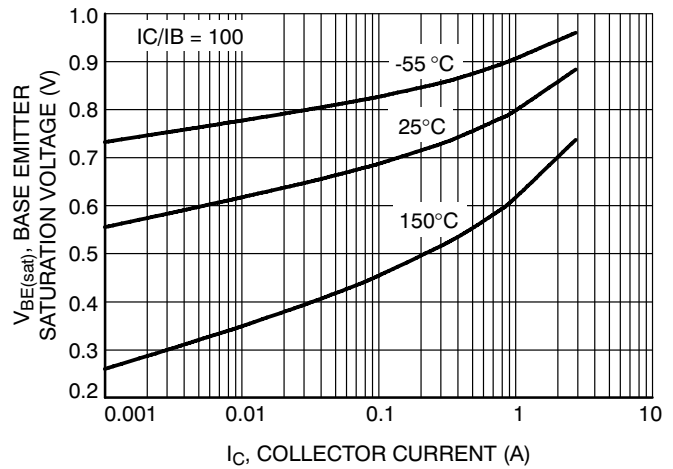


Figure 18. Base Emitter Saturation Voltage vs. Collector Current

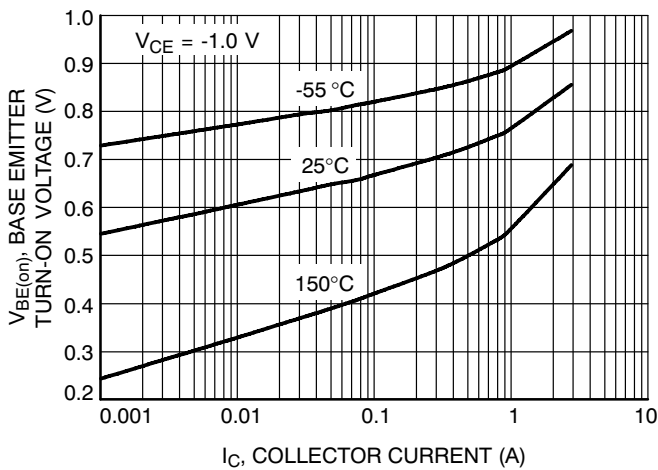


Figure 19. Base Emitter Turn-On Voltage vs. Collector Current

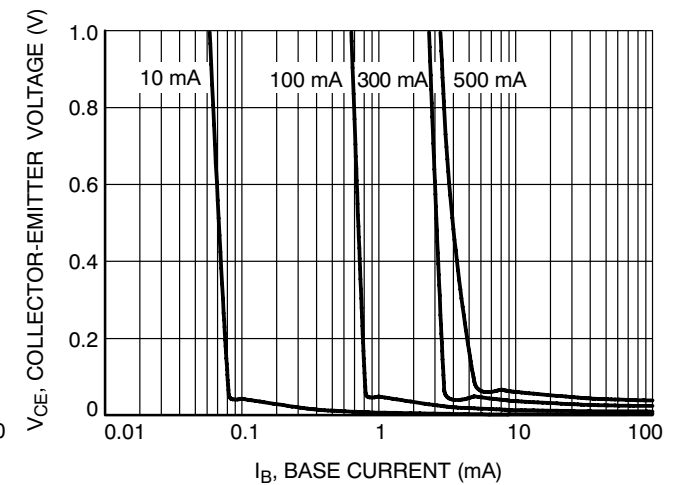


Figure 20. Saturation Region

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TYPICAL CHARACTERISTICS - BJT

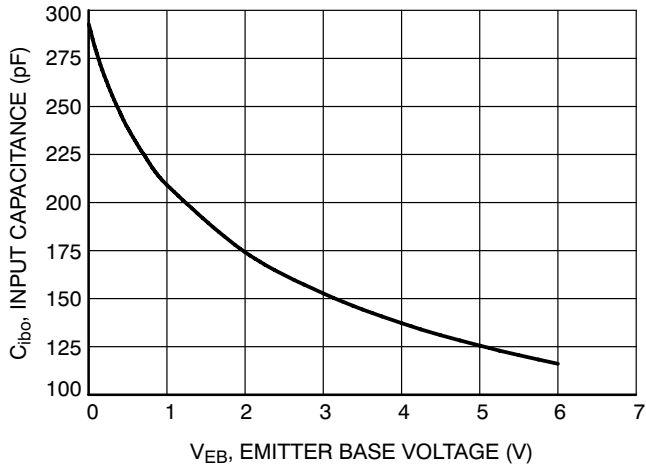


Figure 21. Input Capacitance

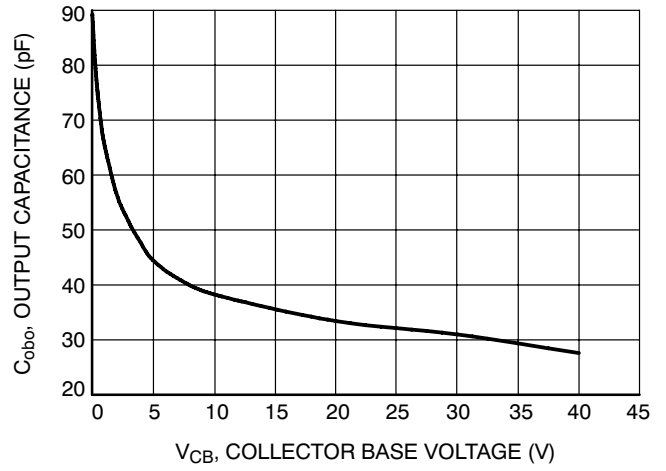
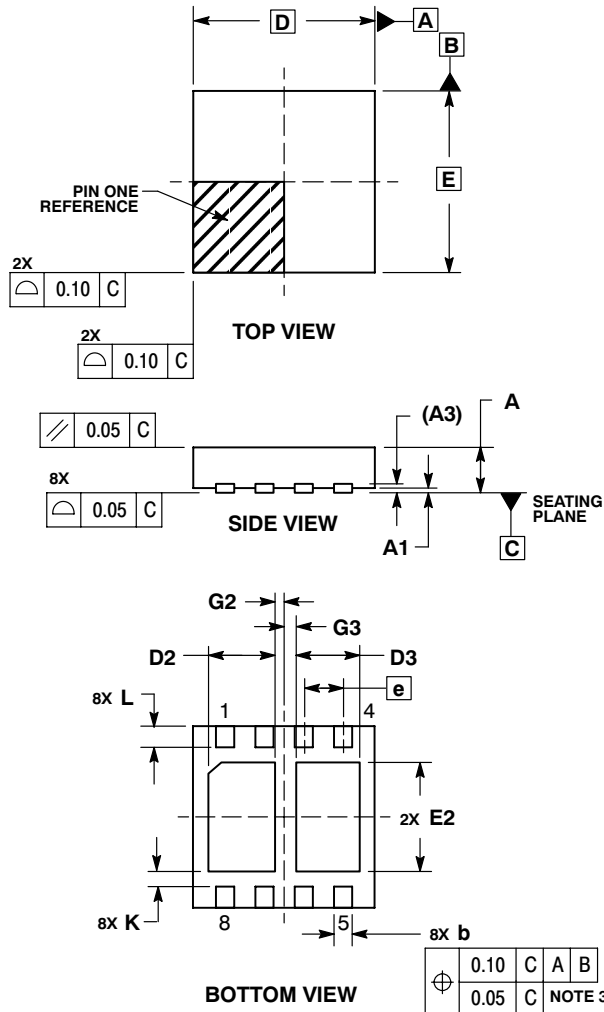


Figure 22. Output Capacitance

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PACKAGE DIMENSIONS

DFN8, 3x3, 0.65P
CASE 506BC-01
ISSUE O



NOTES:

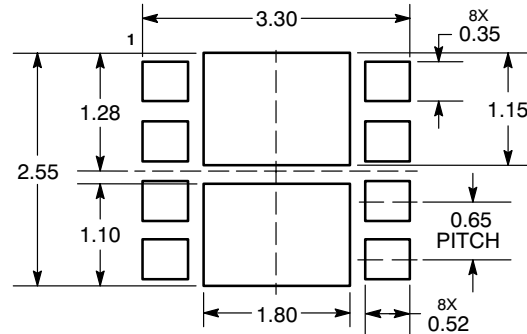
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

MILLIMETERS		
DIM	MIN	MAX
A	0.70	0.80
A1	0.00	0.05
A3	0.20 REF	
b	0.25	0.35
D	3.00 BSC	
D2	1.00	1.20
D3	0.95	1.15
E	3.00 BSC	
E2	1.70	1.90
e	0.65 BSC	
G2	0.15 REF	
G3	0.20 REF	
K	0.20	---
L	0.25	0.45

STYLE 1:

- PIN 1. EMITTER1
2. EMITTER2
3. COLLECTOR
4. SOURCE
5. DRAIN
6. GATE
7. BASE2
8. BASE1

SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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